

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/945,171	SMITH ET AL.
Examiner	Art Unit	
Erin M. File	2634	

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	2/27/2006	EMF
375/295,296.ccls. (cursory)	2/27/2006	EMF
327/291.ccls. (cursory)	2/27/2006	EMF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner